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Details

Product Status	Obsolete
Core Processor	8032
Core Size	8-Bit
Speed	24MHz
Connectivity	I²C, UART/USART
Peripherals	LVR, POR, PWM, WDT
Number of I/O	37
Program Memory Size	160KB (160K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 4x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	52-LQFP
Supplier Device Package	-
Purchase URL	https://www.e-xfl.com/product-detail/stmicroelectronics/upsd3233bv-24t6t

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1 UPSD323xx description

The UPSD323xx Series combines a fast 8051-based microcontroller with a flexible memory structure, programmable logic, and a rich peripheral mix including USB, to form an ideal embedded controller. At its core is an industry-standard 8032 MCU operating up to 40MHz.

A JTAG serial interface is used for In-System Programming (ISP) in as little as 10 seconds, perfect for manufacturing and lab development.

The USB 1.1 low-speed interface has one Control endpoint and two Interrupt endpoints suitable for HID class drivers.

The 8032 core is coupled to Programmable System Device (PSD) architecture to optimize the 8032 memory structure, offering two independent banks of Flash memory that can be placed at virtually any address within 8032 program or data address space, and easily paged beyond 64 Kbytes using on-chip programmable decode logic.

Dual Flash memory banks provide a robust solution for remote product updates in the field through In-Application Programming (IAP). Dual Flash banks also support EEPROM emulation, eliminating the need for external EEPROM chips.

General purpose programmable logic (PLD) is included to build an endless variety of gluelogic, saving external logic devices. The PLD is configured using the software development tool, PSDsoft Express, available from the web at **www.st.com/psm**, at no charge.

The UPSD323xx also includes supervisor functions such as a programmable watchdog timer and low-voltage reset.

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.

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Figure 1. UPSD323xx block diagram



Port	Signal	Pin	In/	Function		
pin	name	no.	out	Basic	Alternate	
P4.7	PWM4	18	I/O	General I/O port pin	Programmable 8-bit Pulse Width modulation output 4	
	USB-	8	I/O	Pull-up resistor required (2 k Ω for 3 V devices, 7.5 k Ω for 5 V devices)		
	V _{REF}	70	0	Reference Voltage input for ADC		
	RD_	65	0	READ signal, external bus		
	WR_	62	0	WRITE signal, external bus		
	PSEN_	63	0	PSEN signal, external bus		
	ALE	4	0	Address Latch signal, external bus		
	RESET_	68	Ι	Active low RESET input		
	XTAL1	48	Ι	Oscillator input pin for system clock		
	XTAL2	49	0	Oscillator output pin for system clock		
PA0		35	I/O	General I/O port pin		
PA1		34	I/O	General I/O port pin		
PA2		32	I/O	General I/O port pin	PLD macrocell outputs	
PA3		28	I/O	General I/O port pin	PLD inputs	
PA4		26	I/O	General I/O port pin	A7)	
PA5		24	I/O	General I/O port pin	Peripheral I/O mode	
PA6		22	I/O	General I/O port pin		
PA7		21	I/O	General I/O port pin		
PB0		80	I/O	General I/O port pin		
PB1		78	I/O	General I/O port pin		
PB2		76	I/O	General I/O port pin		
PB3		74	I/O	General I/O port pin	PLD inputs	
PB4		73	I/O	General I/O port pin	Latched address out (A0-	
PB5		72	I/O	General I/O port pin	A7)	
PB6		67	I/O	General I/O port pin		
PB7		66	I/O	General I/O port pin		

 Table 2.
 80-pin package pin description (continued)



Mnemonic	Operation
ANL C,bit	C = A .AND. bit
ANL C,/bit	C = C .ANDNOT. bit
ORL C,bit	C = A .OR. bit
ORL C,/bit	C = C .ORNOT. bit
MOV C,bit	C = bit
MOV bit,C	bit = C
CLR C	C = 0
CLR bit	bit = 0
SETB C	C = 1
SETB bit	bit = 1
CPL C	C = .NOT. C
CPL bit	bit = .NOT. bit
JC rel	Jump if C =1
JNC rel	Jump if C = 0
JB bit,rel	Jump if bit =1
JNB bit,rel	Jump if bit = 0
JBC bit,rel	Jump if bit = 1; CLR bit

Table 12.Boolean instructions

2.14 Relative offset

The destination address for these jumps is specified to the assembler by a label or by an actual address in Program memory. However, the destination address assembles to a relative offset byte. This is a signed (two's complement) offset byte which is added to the PC in two's complement arithmetic if the jump is executed.

The range of the jump is therefore -128 to +127 Program Memory bytes relative to the first byte following the instruction.

2.15 Jump instructions

Table 13 shows the list of unconditional jump instructions. The table lists a single "JMP add" instruction, but in fact there are three SJMP, LJMP, and AJMP, which differ in the format of the destination address. JMP is a generic mnemonic which can be used if the programmer does not care which way the jump is en-coded.

The SJMP instruction encodes the destination address as a relative offset, as described above. The instruction is 2 bytes long, consisting of the opcode and the relative offset byte. The jump distance is limited to a range of -128 to +127 bytes relative to the instruction following the SJMP.



			•	,				
88	TCON ⁽¹⁾	TMOD	TL0	TL1	TH0	TH1		8F
80	P0 ⁽¹⁾	SP	DPL	DPH			PCON	87

Table 15. SFR memory map (continued)

1. Register can be bit addressing

Table 16.List of all SFRs

dr H	D		set lue	0							
SF	нед мате	7	6	5	4	3	2	1	0	Res Val	Comments
80	P0									FF	Port 0
81	SP									07	Stack Ptr
82	DPL									00	Data Ptr Low
83	DPH									00	Data Ptr High
87	PCON	SMOD	SMOD1	LVREN	ADSFINT	RCLK1	TCLK1	PD	IDLE	00	Power Ctrl
88	TCON	TF1	TR1	TF0	TR0	IE1	IT1	IE0	ITO	00	Timer / Cntr Control
89	TMOD	Gate	C/T	M1	MO	Gate	C/T	M1	MO	00	Timer / Cntr mode Control
8A	TLO									00	Timer 0 Low
8B	TL1									00	Timer 1 Low
8C	TH0									00	Timer 0 High
8D	TH1									00	Timer 1 High
90	P1									FF	Port 1
91	P1SFS	P1S7	P1S6	P1S5	P1S4					00	Port 1 Select Register
93	P3SFS	P3S7	P3S6							00	Port 3 Select Register
94	P4SFS	P4S7	P4S6	P4S5	P4S4	P4S3	P4S2	P4S1	P4S0	00	Port 4 Select Register
95	ASCL									00	8-bit Prescaler for ADC clock
96	ADAT	ADAT7	ADAT6	ADAT5	ADAT4	ADAT3	ADAT2	ADAT1	ADAT0	00	ADC Data Register
97	ACON			ADEN		ADS1	ADS0	ADST	ADSF	00	ADC Control Register
98	SCON	SM0	SM1	SM2	REN	TB8	RB8	ТІ	RI	00	Serial Control Register
99	SBUF									00	Serial Buffer
9A	SCON2	SM0	SM1	SM2	REN	TB8	RB8	ТІ	RI	00	2nd UART Ctrl Register
9B	SBUF2									00	2nd UART Serial Buffer
A0	P2									FF	Port 2



ц.	Den Neme	Bit Register Name									0
SF	нед мате	7	6	5	4	3	2	1	0	Res Val	Comments
A1	PWMCON	PWML	PWMP	PWME	CFG4	CFG3	CFG2	CFG1	CFG0	00	PWM Control Polarity
A2	PWM0									00	PWM0 Output Duty Cycle
A3	PWM1									00	PWM1 Output Duty Cycle
A4	PWM2									00	PWM2 Output Duty Cycle
A5	PWM3									00	PWM3 Output Duty Cycle
A6	WDRST									00	Watch Dog Reset
A7	IEA	EDDC			ES2			El ² C	EUSB	00	Interrupt Enable (2nd)
A8	IE	EA	-	ET2	ES	ET1	EX1	ET0	EX0	00	Interrupt Enable
A9											
AA	PWM4P									00	PWM 4 Period
AB	PWM4W									00	PWM 4 Pulse Width
AE	WDKEY									00	Watch Dog Key Register
B0	P3									FF	Port 3
B1	PSCL0L									00	Prescaler 0 Low (8-bit)
B2	PSCL0H									00	Prescaler 0 High (8-bit)
В3	PSCL1L									00	Prescaler 1 Low (8-bit)
B4	PSCL1H									00	Prescaler 1 High (8-bit)
B7	IPA	PDDC			PS2			PI2C	PUSB	00	Interrupt Priority (2nd)
B8	IP			PT2	PS	PT1	PX1	PT0	PX0	00	Interrupt Priority
C0	P4									FF	New Port 4
C8	T2CON	TF2	EXF2	RCLK	TCLK	EXEN2	TR2	C/T2	CP/RL2	00	Timer 2 Control

Table 16. List of all SFRs (continued)



5 Interrupt system

There are interrupt requests from 10 sources as follows.

- INT0 external interrupt
- 2nd USART interrupt
- Timer 0 interrupt
- I²C interrupt
- INT1 external interrupt (or ADC interrupt)
- DDC interrupt
- Timer 1 interrupt
- USB interrupt
- USART interrupt
- Timer 2 interrupt

5.1 External Int0 interrupt

- The INT0 can be either level-active or transition-active depending on Bit IT0 in register TCON. The flag that actually generates this interrupt is Bit IE0 in TCON.
- When an external interrupt is generated, the corresponding request flag is cleared by the hardware when the service routine is vectored to only if the interrupt was transition activated.
- If the interrupt was level activated then the interrupt request flag remains set until the requested interrupt is actually generated. Then it has to deactivate the request before the interrupt service routine is completed, or else another interrupt will be generated.

5.2 Timer 0 and 1 interrupts

- Timer 0 and Timer 1 Interrupts are generated by TF0 and TF1 which are set by an overflow of their respective Timer/Counter registers (except for Timer 0 in Mode 3).
- These flags are cleared by the internal hardware when the interrupt is serviced.

5.3 Timer 2 interrupt

- Timer 2 Interrupt is generated by TF2 which is set by an overflow of Timer 2. This flag has to be cleared by the software not by hardware.
- It is also generated by the T2EX signal (Timer 2 External Interrupt P1.1) which is controlled by EXEN2 and EXF2 Bits in the T2CON register.

5.4 I²C interrupt

- The interrupt of the I²C is generated by Bit INTR in the register S2STA.
- This flag is cleared by hardware.



9.3 Watchdog timer overflow

The Watchdog timer generates an internal reset when its 22-bit counter overflows. See Watchdog Timer section for details.

9.4 USB reset

The USB reset is generated by a detection on the USB bus RESET signal. A single-end zero on its upstream port for 4 to 8 times will set RSTF Bit in UISTA register. If Bit 6 (RSTE) of the UIEN Register is set, the detection will also generate the RESET signal to reset the CPU and other peripherals in the MCU.



11 Timer/counters (Timer 0, Timer 1 and Timer 2)

The UPSD323xx devices has three 16-bit Timer/Counter registers: Timer 0, Timer 1 and Timer 2. All of them can be configured to operate either as timers or event counters and are compatible with standard 8032 architecture.

In the "Timer" function, the register is incremented every machine cycle. Thus, one can think of it as counting machine cycles. Since a machine cycle consists of 6 CPU clock periods, the count rate is 1/6 of the CPU clock frequency or 1/12 of the oscillator frequency (f_{OSC}).

In the "Counter" function, the register is incremented in response to a 1-to-0 transition at its corresponding external input pin, T0 or T1. In this function, the external input is sampled during S5P2 of every machine cycle. When the samples show a high in one cycle and a low in the next cycle, the count is incremented. The new count value appears in the register during S3P1 of the cycle following the one in which the transition was detected. Since it takes 2 machine cycles ($24 f_{OSC}$ clock periods) to recognize a 1-to-0 transition, the maximum count rate is 1/24 of the f_{OSC} . There are no restrictions on the duty cycle of the external input signal, but to ensure that a given level is sampled at least once before it changes, it should be held for at least one full cycle. In addition to the "Timer" or "Counter" selection, Timer 0 and Timer 1 have four operating modes from which to select.

11.1 Timer 0 and Timer 1

The "Timer" or "Counter" function is selected by control bits C/ T in the Special Function Register TMOD. These Timer/Counters have four operating modes, which are selected by bit-pairs (M1, M0) in TMOD. Modes 0, 1, and 2 are the same for Timers/ Counters. Mode 3 is different. The four operating modes are de-scribed in the following text.

Table 36.	Control re	egister (TC	ON)				
7	6	5	4	3	2	1	
TF1	TR1	TF0	TR0	IE1	IT1	IE0	

Table 37. Description of the TCON bits

. .

Bit	Symbol	Function
7	TF1	Timer 1 overflow flag. Set by hardware on Timer/Counter overflow. Cleared by hardware when processor vectors to interrupt routine
6	TR1	Timer 1 run control bit. Set/cleared by software to turn Timer/Counter on or off
5	TF0	Timer 0 overflow flag. Set by hardier on Timer/Counter overflow. Cleared by hardware when processor vectors to interrupt routine
4	TR0	Timer 0 run control bit. Set/cleared by software to turn Timer/Counter on or off
3	IE1	Interrupt 1 Edge Flag. Set by hardware when external interrupt edge detected. Cleared when interrupt processed
2	IT1	Interrupt 1 Type Control Bit. Set/cleared by software to specify falling- edge/low-level triggered external interrupt

0 IT0 As data bits shift out to the right, zeros are clocked in from the left. When the MSB of the data byte is at the output position of the shift register, then the '1' that was initially loaded into the 9th position is just to the left of the MSB, and all positions to the left of that contain zeros. This condition flags the TX Control unit to do one last shift and then deactivate SEND and set TI. This occurs at the 10th divide-by-16 rollover after "WRITE to SBUF."

Reception is initiated by a detected 1-to-0 transition at RxD. For this purpose RxD is sampled at a rate of 16 times whatever baud rate has been established. When a transition is detected, the divide-by-16 counter is immediately reset, and 1FFH is written into the input shift register. Resetting the divide-by-16 counter aligns its roll-overs with the boundaries of the incoming bit times.

The 16 states of the counter divide each bit time into 16ths. At the 7th, 8th, and 9th counter states of each bit time, the bit detector samples the value of RxD. The value accepted is the value that was seen in at least 2 of the 3 samples. This is done for noise rejection. If the value accepted during the first bit time is not '0,' the receive circuits are reset and the unit goes back to looking for an-other 1-to-0 transition. This is to provide rejection of false start bits. If the start bit proves valid, it is shifted into the input shift register, and reception of the reset of the reset of the frame will proceed.

As data bits come in from the right, '1s' shift out to the left. When the start bit arrives at the left-most position in the shift register (which in Mode 1 is a 9-bit register), it flags the RX Control block to do one last shift, load SBUF and RB8, and set RI. The signal to load SBUF and RB8, and to set RI, will be generated if, and only if, the following conditions are met at the time the final shift pulse is generated:

- 1. R1 = 0, and
- 2. Either SM2 = 0, or the received Stop bit = 1.

If either of these two conditions is not met, the received frame is irretrievably lost. If both conditions are met, the Stop bit goes into RB8, the 8 data bits go into SBUF, and RI is activated. At this time, whether the above conditions are met or not, the unit goes back to looking for a 1-to-0 transition in RxD.

12.2.6 More about Modes 2 and 3

Eleven bits are transmitted (through TxD), or received (through RxD): a Start bit (0), 8 data bits (LSB first), a programmable 9th data bit, and a Stop bit (1). On transmit, the 9th data bit (TB8) can be assigned the value of '0' or '1.' On receive, the data bit goes into RB8 in SCON. The baud rate is programmable to either 1/16 or 1/32 the CPU clock frequency in Mode 2. Mode 3 may have a variable baud rate generated from Timer 1.

Figure 30 and *Figure 32* show a functional diagram of the serial port in Modes 2 and 3. The receive portion is exactly the same as in Mode 1. The transmit portion differs from Mode 1 only in the 9th bit of the transmit shift register.

Transmission is initiated by any instruction that uses SBUF as a destination register. The "WRITE to SBUF" signal also loads TB8 into the 9th bit position of the transmit shift register and flags the TX Control unit that a transmission is requested. Transmission commences at S1P1 of the machine cycle following the next roll-over in the divide-by-16 counter. (Thus, the bit times are synchronized to the divide-by-16 counter, not to the "WRITE to SBUF" signal.)

The transmission begins with activation of SEND, which puts the start bit at TxD. One bit time later, DATA is activated, which enables the output bit of the transmit shift register to TxD. The first shift pulse occurs one bit time after that. The first shift clocks a '1' (the Stop bit) into the 9th bit position of the shift register. There-after, only zeros are clocked in. Thus,



Bit	Symbol	R/W	Function
4	TXD0F	R/W	Endpoint0 Data Transmit Flag. This bit is set after the data stored in Endpoint 0 transmit buffers has been sent and an ACK handshake packet from the host is received. Once the next set of data is ready in the transmit buffers, software must clear this flag. To enable the next data packet transmission, TX0E must also be set. If TXD0F Bit is not cleared, a NAK handshake will be returned in the next IN transactions. RESET clears this bit.
3	RXD0F	R/W	Endpoint0 Data Receive Flag. This bit is set after the USB module has received a data packet and responded with ACK handshake packet. Software must clear this flag after all of the received data has been read. Software must also set RX0E Bit to one to enable the next data packet reception. If RXD0F Bit is not cleared, a NAK handshake will be returned in the next OUT transaction. RESET clears this bit.
2	TXD1F	R/W	Endpoint1 / Endpoint2 Data Transmit Flag. This bit is shared by Endpoints 1 and Endpoints 2. It is set after the data stored in the shared Endpoint 1/ Endpoint 2 transmit buffer has been sent and an ACK handshake packet from the host is received. Once the next set of data is ready in the transmit buffers, software must clear this flag. To enable the next data packet transmission, TX1E must also be set. If TXD1F Bit is not cleared, a NAK handshake will be returned in the next IN transaction. RESET clears this bit.
1	EOPF	R/W	End of Packet Flag. This bit is set when a valid End of Packet sequence is detected on the D+ and D-line. Software must clear this flag. RESET clears this bit.
0	RESUMF	R/W	Resume Flag. This bit is set when USB bus activity is detected while the SUSPND Bit is set. Software must clear this flag. RESET clears this bit.

 Table 68.
 Description of the UISTA bits (continued)

Table 69	USB Endpoint0 transmit control register (UCON0: 0EAh)
Table 09.	USB Enupointo transmit control register (UCONU. UEAII)

7	6	5	4	3	2	1	0
TSEQ0	STALL0	TX0E	RX0E	TP0SIZ3	TP0SIZ2	TP0SIZ1	TP0SIZ0

AND Array, ORed with the Direction Register output. The pin is enabled upon Power-up if no output enable equation is defined and if the pin is declared as a PLD output in PSDsoft Express.

If the Output Macrocell (OMC) output is declared as an internal node and not as a port pin output in the PSDabel file, the port pin can be used for other I/O functions. The internal node feedback can be routed as an input to the AND Array.

23.6 Input macrocells (IMC)

The CPLD has 20 Input Macrocells (IMC), one for each pin on Ports A and B, and 4 on Port C. The architecture of the Input Macrocells (IMC) is shown in *Figure 60*. The Input Macrocells (IMC) are individually configurable, and can be used as a latch, register, or to pass incoming Port signals prior to driving them onto the PLD input bus. The outputs of the Input Macrocells (IMC) can be read by the MCU through the internal data bus.

The enable for the latch and clock for the register are driven by a multiplexer whose inputs are a product term from the CPLD AND Array or the MCU Address Strobe (ALE). Each product term output is used to latch or clock four Input Macrocells (IMC). Port inputs 3-0 can be controlled by one product term and 7-4 by another.

Configurations for the Input Macrocells (IMC) are specified by equations written in PSDsoft (see Application Note *AN1171*). Outputs of the Input Macrocells (IMC) can be read by the MCU via the IMC buffer.

See Section 24: I/O ports (PSD module).



Figure 60. Input macrocell





Figure 61. General I/O port architecture

The Port pin's tri-state output driver enable is controlled by a two input OR gate whose inputs come from the CPLD AND Array enable product term and the Direction Register. If the enable product term of any of the Array outputs are not defined and that port pin is not defined as a CPLD output in the PSDsoft, then the Direction Register has sole control of the buffer that drives the port pin.

The contents of these registers can be altered by the MCU. The Port Data Buffer (PDB) feedback path allows the MCU to check the contents of the registers.

Ports A, B, and C have embedded Input Macrocells (IMC). The Input Macrocells (IMC) can be configured as latches, registers, or direct inputs to the PLDs. The latches and registers are clocked by Address Strobe (ALE) or a product term from the PLD AND Array. The outputs from the Input Macrocells (IMC) drive the PLD input bus and can be read by the MCU. See *Figure 60*.

24.2 Port operating modes

The I/O Ports have several modes of operation. Some modes can be defined using PSDsoft, some by the MCU writing to the Control Registers in CSIOP space, and some by both. The modes that can only be defined using PSDsoft must be programmed into the device and cannot be changed unless the device is reprogrammed. The modes that can be changed by the MCU can be done so dynamically at run-time. The PLD I/O, Data Port, Address Input, and Peripheral I/O modes are the only modes that must be defined before programming the device. All other modes can be changed by the MCU at run-time. See Application Note *AN1171* for more detail.

Table 93 summarizes which modes are available on each port. *Table 96* shows how and where the different modes are configured. Each of the port operating modes are described in the following sections.



are not set, writing to the macrocell loads data to the macrocell flip-flops. See *Section 23: PLDs*.

24.9.4 OMC mask register

Each OMC Mask Register Bit corresponds to an Output Macrocell (OMC) flip-flop. When the OMC Mask Register Bit is set to a '1,' loading data into the Output Macrocell (OMC) flip-flop is blocked. The default value is '0' or unblocked.

24.9.5 Input macrocells (IMC)

The Input Macrocells (IMC) can be used to latch or store external inputs. The outputs of the Input Macrocells (IMC) are routed to the PLD input bus, and can be read by the MCU. See *Section 23: PLDs*.

24.9.6 Enable out

The Enable Out register can be read by the MCU. It contains the output enable values for a given port. A '1' indicates the driver is in output mode. A '0' indicates the driver is in tri-state and the pin is in input mode.

Drive Register	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
Port A	Open	Open	Open	Open	Slew	Slew	Slew	Slew
	Drain	Drain	Drain	Drain	Rate	Rate	Rate	Rate
Port B	Open	Open	Open	Open	Slew	Slew	Slew	Slew
	Drain	Drain	Drain	Drain	Rate	Rate	Rate	Rate
Port C	Open	Open	Open	Open	Open	Open	Open	Open
	Drain	Drain	Drain	Drain	Drain	Drain	Drain	Drain
Port D	NA ⁽¹⁾	Slew Rate	Slew Rate	NA ⁽¹⁾				

Table 100. Drive register pin assignment

1. NA = Not Applicable.

Table 101. Port data registers

Register Name	Port	MCU Access
Data In	A,B,C,D	READ – input on pin
Data Out A,B,C,D WRITE/READ		WRITE/READ
Output Macrocell	A,B,C	READ – outputs of macrocells WRITE – loading macrocells flip-flop
Mask Macrocell	A,B,C	WRITE/READ – prevents loading into a given macrocell
Input Macrocell	A,B,C	READ – outputs of the Input Macrocells
Enable Out	A,B,C	READ – the output enable control of the port driver



Conditions							
Calculation (using typical values)							
	= I _{CC} (MCUactive) x %MCUactive + I _{CC} (PSDactive) x %PSDactive + I _{PD} (pwrdown) x %pwrdown						
	I _{CC} (MCUactive)	= 20mA					
I _{CC} total	I _{PD} (pwrdown)	= 250µA					
	I _{CC} (PSDactive)	$= I_{CC}(ac) + I_{C}$	_C (dc)				
		= %flash x 2.8	5mA/MHz x Freq ALE				
		+ %SRAM x 1.5mA/MH ALE					
			+ % PLD x (from graph using Freq PLD)				
		= 0.8 x 2.5mA/MHz x 2MHz + 0.15 x 1.5mA/MHz x 2MHz + 24mA					
		= (4 + 0.45 + 24) mA					
		= 28.45mA					
I _{CC} total	= 20mA x 40% + 28.45mA x 40% + 2	50μA x 60%					
		= 8mA + 11.3	8mA + 150µA				
	= 19.53mA						
This is the op is based on a	erating power with no Flash memory E II I/O pins being disconnected and I _{OUT}	rase or Prograr = 0mA.	n cycles in progress. Calculation				

Table 108. PSD module example, typ. power calculation at $V_{CC} = 5.0 V$ (Turbo mode off) (continued)



31 EMC characteristics

Susceptibility test are performed on a sample basis during product characterization.

31.1 Functional EMS (electromagnetic susceptibility)

Based on a simple running application on the product (toggling 2 LEDs through I/O ports), the product is stressed by two electromagnetic events until a failure occurs (indicated by the LEDs).

31.1.1 ESD

Electro-Static Discharge (positive and negative) is applied on all pins of the device until a functional disturbance occurs. This test conforms with the IEC 1000-4-2 Standard.

31.1.2 FTB

A burst of Fast Transient voltage (positive and negative) is applied to V_{DD} and V_{SS} through a 100pF capacitor, until a functional disturbance occurs. This test conforms with the IEC 1000-4-2 Standard.

A device reset allows normal operations to be resumed. The test results are given in *Table 110*, based on the EMS levels and classes defined in Application Note AN1709.

31.2 Designing hardened software to avoid noise problems

EMC characterization and optimization are performed at component level with a typical application environment and simplified MCU software. It should be noted that good EMC performance is highly dependent on the user application and the software in particular.

Therefore, it is recommended that the user applies EMC software optimization and prequalification tests in relation with the EMC level requested for the user's application.

31.2.1 Software recommendations

The software flowchart must include the management of 'runaway' conditions, such as:

- Corrupted program counter
- Unexpected reset
- Critical data corruption (e.g., control registers)

31.2.2 Prequalification trials

Most of the common failures (unexpected reset and program counter corruption) can be reproduced by manually forcing a low state on the RESET pin or the oscillator pins for 1 second.

To complete these trials, ESD stress can be applied directly on the device over the range of specification values. When unexpected behavior is detected, the software can be hardened to prevent unrecoverable errors occurring (see Application Note AN1015).





Figure 81. Peripheral I/O Read timing

Table 137.	Port A peripheral	data mode Read	timing (5 V devices)
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Symbol	Parameter	Condition s	Min.	Max.	Turbo off	Unit
t _{AVQV-PA}	Address valid to data valid	(Note 1)		37	+ 10	ns
t _{SLQV-PA}	CSI valid to data valid			27	+ 10	ns
t _{RLQV-PA}	RD to data valid	(Note 2)		32		ns
t _{DVQV-PA}	Data in to data out valid			22		ns
t _{RHQZ-PA}	RD to data high-Z			23		ns

1. Any input used to select Port A Data Peripheral mode.

2. Data is already stable on Port A.

Table 138. Port A peripheral data mode Read timing (3 V devices)

Symbol	Parameter	Conditions	Min.	Max.	Turbo off	Unit
t _{AVQV-PA}	Address valid to data valid	(Note 1)		50	+ 20	ns
t _{SLQV-PA}	CSI valid to data valid			37	+ 20	ns
t _{RLQV-PA}	RD to data valid	(Note 2)		45		ns
t _{DVQV-PA}	Data in to data out valid			38		ns
t _{RHQZ-PA}	RD to data high-Z			36		ns

1. Any input used to select Port A Data Peripheral mode.

2. Data is already stable on Port A.



Symbol	Parameter	Conditions	Min.	Max.	Unit
t _{ISCCF}	Clock (TCK, PC1) frequency (except for PLD)	(Note 1)		20	MHz
t _{ISCCH}	Clock (TCK, PC1) high time (except for PLD)	(Note 1)	23		ns
t _{ISCCL}	Clock (TCK, PC1) low time (except for PLD)	(Note 1)	23		ns
t _{ISCCFP}	Clock (TCK, PC1) frequency (PLD only)	(Note 2)		2	MHz
t _{ISCCHP}	Clock (TCK, PC1) high time (PLD only)	(Note 2)	240		ns
t _{ISCCLP}	Clock (TCK, PC1) low time (PLD only)	(Note 2)	240		ns
t _{ISCPSU}	ISC port set-up time		7		ns
t _{ISCPH}	ISC port hold-up time		5		ns
t _{ISCPCO}	ISC port clock to output			21	ns
t _{ISCPZV}	ISC port high-impedance to valid output			21	ns
t _{ISCPVZ}	ISC port valid output to high-impedance			21	ns

Table 143. ISC timing (5 V devices)

1. For non-PLD Programming, Erase or in ISC By-pass mode.

2. For Program or Erase PLD only.

Table 144. ISC timing (3 V devices)

Symbol	Parameter	Conditions	Min.	Max.	Unit
t _{ISCCF}	Clock (TCK, PC1) frequency (except for PLD)	(Note 1)		12	MHz
t _{ISCCH}	Clock (TCK, PC1) high time (except for PLD)	(Note 1)	40		ns
t _{ISCCL}	Clock (TCK, PC1) low time (except for PLD)	(Note 1)	40		ns
t _{ISCCFP}	Clock (TCK, PC1) frequency (PLD only)	(Note 2)		2	MHz
t _{ISCCHP}	Clock (TCK, PC1) high time (PLD only)	(Note 2)	240		ns
t _{ISCCLP}	Clock (TCK, PC1) low time (PLD only)	(Note 2)	240		ns
t _{ISCPSU}	ISC port set-up time		12		ns
t _{ISCPH}	ISC port hold-up time		5		ns
t _{ISCPCO}	ISC port clock to output			30	ns
t _{ISCPZV}	ISC port high-impedance to valid output			30	ns
t _{ISCPVZ}	ISC port valid output to high-impedance			30	ns

1. For non-PLD Programming, Erase or in ISC By-pass mode.

2. For Program or Erase PLD only.

Figure 85. MCU module AC measurement I/O waveform



- 1. AC inputs during testing are driven at V_{CC}\!-\!0.5 V for a logic '1,' and 0.45 V for a logic '0.'
- 2. Timing measurements are made at $V_{IH}(\mbox{min})$ for a logic '1,' and $V_{IL}(\mbox{max})$ for a logic '0'.





Figure 92. LQFP80 – 80-lead plastic thin, quad, flat package outline

1. Drawing is not to scale.

Table 147.	LQFP80 -	- 80-lead plastic	thin, quad, flat	package mechanical data
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Symbol		millimeters			inches ⁽¹⁾		
Symbol	Тур	Min	Max	Тур	Min	Max	
А			1.600			0.0630	
A1		0.050	0.150		0.0020	0.0059	
A2	1.400	1.350	1.450	0.0551	0.0531	0.0571	
b	0.220	0.170	0.270	0.0087	0.0067	0.0106	
С		0.090	0.200		0.0035	0.0079	
D	14.000			0.5512			
D1	12.000			0.4724			
D3	9.500			0.3740			
E	14.000			0.5512			
E1	12.000			0.4724			
E3	9.500			0.3740			
е	0.500			0.0197			
L	0.600	0.450	0.750	0.0236	0.0177	0.0295	
L1	1.000			0.0394			
k		0°	7 °		0°	7 °	
CCC		0.080			0.0031		

1. Values in inches are converted from mm and rounded to 4 decimal digits.